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Understanding [Embedded - CPLDs \(Complex Programmable Logic Devices\)](#)

Embedded - CPLDs, or Complex Programmable Logic Devices, are highly versatile digital logic devices used in electronic systems. These programmable components are designed to perform complex logical operations and can be customized for specific applications. Unlike fixed-function ICs, CPLDs offer the flexibility to reprogram their configuration, making them an ideal choice for various embedded systems. They consist of a set of logic gates and programmable interconnects, allowing designers to implement complex logic circuits without needing custom hardware.

Applications of Embedded - CPLDs

Details

Product Status	Active
Programmable Type	In System Programmable
Delay Time tpd(1) Max	9.2 ns
Voltage Supply - Internal	1.7V ~ 1.9V
Number of Logic Elements/Blocks	24
Number of Macrocells	384
Number of Gates	9000
Number of I/O	240
Operating Temperature	0°C ~ 70°C (TA)
Mounting Type	Surface Mount
Package / Case	324-BBGA
Supplier Device Package	324-FBGA (23x23)
Purchase URL	https://www.e-xfl.com/product-detail/xilinx/xc2c384-10fgg324c

Absolute Maximum Ratings ⁽¹⁾

Symbol	Description	Value	Units
V_{CC}	Supply voltage relative to ground	–0.5 to 2.0	V
V_{CCIO}	Supply voltage for output drivers	–0.5 to 4.0	V
$V_{JTAG}^{(2)}$	JTAG input voltage limits	–0.5 to 4.0	V
V_{CCAUX}	JTAG input supply voltage	–0.5 to 4.0	V
$V_{IN}^{(1)}$	Input voltage relative to ground	–0.5 to 4.0	V
$V_{TS}^{(1)}$	Voltage applied to 3-state output	–0.5 to 4.0	V
$T_{STG}^{(3)}$	Storage Temperature (ambient)	–65 to +150	°C
T_J	Junction Temperature	+150	°C

Notes:

- Maximum DC undershoot below GND must be limited to either 0.5V or 10 mA, whichever is easiest to achieve. During transitions, the device pins may undershoot to –2.0V or overshoot to +4.5V, provided this over or undershoot lasts less than 10 ns and with the forcing current being limited to 200 mA.
- Valid over commercial temperature range.
- For soldering guidelines and thermal considerations, see the [Device Packaging](#) information on the Xilinx website. For Pb free packages, see [XAPP427](#).

Recommended Operating Conditions

Symbol	Parameter		Min	Max	Units
V _{CC}	Supply voltage for internal logic and input buffers	Commercial T _A = 0°C to +70°C	1.7	1.9	V
		Industrial T _A = −40°C to +85°C	1.7	1.9	V
V _{CCIO}	Supply voltage for output drivers @ 3.3V operation		3.0	3.6	V
	Supply voltage for output drivers @ 2.5V operation		2.3	2.7	V
	Supply voltage for output drivers @ 1.8V operation		1.7	1.9	V
	Supply voltage for output drivers @ 1.5V operation		1.4	1.6	V
V _{CCAUX}	Supply voltage for JTAG programming		1.7	3.6	V

DC Electrical Characteristics (Over Recommended Operating Conditions)

Symbol	Parameter	Test Conditions	Typical	Max.	Units
I_{CCSB}	Standby current Commercial	$V_{CC} = 1.9\text{V}$, $V_{CCIO} = 3.6\text{V}$	44	200	μA
I_{CCSB}	Standby current Industrial	$V_{CC} = 1.9\text{V}$, $V_{CCIO} = 3.6\text{V}$	79	350	μA
$I_{CC}^{(1)}$	Dynamic current	$f = 1\text{ MHz}$		1.5	mA
		$f = 50\text{ MHz}$		45	mA
C_{JTAG}	JTAG input capacitance	$f = 1\text{ MHz}$	-	10	pF
C_{CLK}	Global clock input capacitance	$f = 1\text{ MHz}$	-	12	pF
C_{IO}	I/O capacitance	$f = 1\text{ MHz}$	-	10	pF
$I_{IL}^{(2)}$	Input leakage current	$V_{IN} = 0\text{V}$ or V_{CCIO} to 3.9V	-	+/-1	μA
$I_{IH}^{(2)}$	I/O High-Z leakage	$V_{IN} = 0\text{V}$ or V_{CCIO} to 3.9V	-	+/-1	μA

Notes:

- 16-bit up/down, Resettable binary counter (one counter per function block).
- See Quality and Reliability section of the CoolRunner-II family data sheet.

LVC MOS and LV TTL 3.3V DC Voltage Specifications

Symbol	Parameter	Test Conditions	Min.	Max.	Units
V_{CCIO}	Input source voltage		3.0	3.6	V
V_{IH}	High level input voltage		2	3.9	V
V_{IL}	Low level input voltage		-0.3	0.8	V
V_{OH}	High level output voltage	$I_{OH} = -8\text{ mA}, V_{CCIO} = 3\text{V}$	$V_{CCIO} - 0.4\text{V}$	-	V
		$I_{OH} = -0.1\text{ mA}, V_{CCIO} = 3\text{V}$	$V_{CCIO} - 0.2\text{V}$	-	V
V_{OL}	Low level output voltage	$I_{OL} = 8\text{ mA}, V_{CCIO} = 3\text{V}$	-	0.4	V
		$I_{OL} = 0.1\text{ mA}, V_{CCIO} = 3\text{V}$	-	0.2	V

LVC MOS 2.5V DC Voltage Specifications

Symbol	Parameter	Test Conditions	Min.	Max.	Units
V_{CCIO}	Input source voltage		2.3	2.7	V
V_{IH}	High level input voltage		1.7	$V_{CCIO} + 0.3^{(1)}$	V
V_{IL}	Low level input voltage		-0.3	0.7	V
V_{OH}	High level output voltage	$I_{OH} = -8\text{ mA}, V_{CCIO} = 2.3\text{V}$	$V_{CCIO} - 0.4\text{V}$	-	V
		$I_{OH} = -0.1\text{ mA}, V_{CCIO} = 2.3\text{V}$	$V_{CCIO} - 0.2\text{V}$	-	V
V_{OL}	Low level output voltage	$I_{OL} = 8\text{ mA}, V_{CCIO} = 2.3\text{V}$	-	0.4	V
		$I_{OL} = 0.1\text{ mA}, V_{CCIO} = 2.3\text{V}$	-	0.2	V

(1) The V_{IH} Max value represents the JEDEC specification for LVC MOS25. The CoolRunner-II input buffer can tolerate up to 3.9V without physical damage.

LVC MOS 1.8V DC Voltage Specifications

Symbol	Parameter	Test Conditions	Min.	Max.	Units
V_{CCIO}	Input source voltage		1.7	1.9	V
V_{IH}	High level input voltage		$0.65 \times V_{CCIO}$	$V_{CCIO} + 0.3^{(1)}$	V
V_{IL}	Low level input voltage		-0.3	$0.35 \times V_{CCIO}$	V
V_{OH}	High level output voltage	$I_{OH} = -8\text{ mA}, V_{CCIO} = 1.7\text{V}$	$V_{CCIO} - 0.45$	-	V
		$I_{OH} = -0.1\text{ mA}, V_{CCIO} = 1.7\text{V}$	$V_{CCIO} - 0.2$	-	V
V_{OL}	Low level output voltage	$I_{OL} = 8\text{ mA}, V_{CCIO} = 1.7\text{V}$	-	0.45	V
		$I_{OL} = 0.1\text{ mA}, V_{CCIO} = 1.7\text{V}$	-	0.2	V

(1) The V_{IH} Max value represents the JEDEC specification for LVC MOS18. The CoolRunner-II input buffer can tolerate up to 3.9V without physical damage.

LVC MOS 1.5V DC Voltage Specifications⁽¹⁾

Symbol	Parameter	Test Conditions	Min.	Max.	Units
V_{CCIO}	Input source voltage		1.4	1.6	V
V_{T+}	Input hysteresis threshold voltage		$0.5 \times V_{CCIO}$	$0.8 \times V_{CCIO}$	V
V_{T-}			$0.2 \times V_{CCIO}$	$0.5 \times V_{CCIO}$	V
V_{OH}	High level output voltage	$I_{OH} = -8\text{ mA}, V_{CCIO} = 1.4\text{V}$	$V_{CCIO} - 0.45$	-	V
		$I_{OH} = -0.1\text{ mA}, V_{CCIO} = 1.4\text{V}$	$V_{CCIO} - 0.2$	-	V

Symbol	Parameter	Test Conditions	Min.	Max.	Units
V_{OL}	Low level output voltage	$I_{OL} = 8 \text{ mA}$, $V_{CCIO} = 1.4\text{V}$	-	0.4	V
		$I_{OL} = 0.1 \text{ mA}$, $V_{CCIO} = 1.4\text{V}$	-	0.2	V

Notes:

1. Hysteresis used on 1.5V inputs.

Schmitt Trigger Input DC Voltage Specifications

Symbol	Parameter	Test Conditions	Min.	Max.	Units
V_{CCIO}	Input source voltage		1.4	3.9	V
V_{T+}	Input hysteresis threshold voltage		$0.5 \times V_{CCIO}$	$0.8 \times V_{CCIO}$	V
V_{T-}			$0.2 \times V_{CCIO}$	$0.5 \times V_{CCIO}$	V

SSTL2-1 DC Voltage Specifications

Symbol	Parameter	Test Conditions	Min.	Typ	Max.	Units
V_{CCIO}	Input source voltage	-	2.3	2.5	2.7	V
$V_{REF(1)}$	Input reference voltage	-	1.15	1.25	1.35	V
$V_{TT(2)}$	Termination voltage	-	$V_{REF} - 0.04$	1.25	$V_{REF} + 0.04$	V
V_{IH}	High level input voltage	-	$V_{REF} + 0.18$	-	3.9	V
V_{IL}	Low level input voltage	-	-0.3	-	$V_{REF} - 0.18$	V
V_{OH}	High level output voltage	$I_{OH} = -8 \text{ mA}$, $V_{CCIO} = 2.3\text{V}$	$V_{CCIO} - 0.62$	-	-	V
V_{OL}	Low level output voltage	$I_{OL} = 8 \text{ mA}$, $V_{CCIO} = 2.3\text{V}$	-	-	0.54	V

Notes:

1. V_{REF} should track the variations in V_{CCIO} , also peak to peak AC noise on V_{REF} may not exceed $\pm 2\% V_{REF}$.
2. V_{TT} of transmitting device must track V_{REF} of receiving devices.

SSTL3-1 DC Voltage Specifications

Symbol	Parameter	Test Conditions	Min.	Typ	Max.	Units
V_{CCIO}	Input source voltage	-	3.0	3.3	3.6	V
$V_{REF(1)}$	Input reference voltage	-	1.3	1.5	1.7	V
$V_{TT(2)}$	Termination voltage	-	$V_{REF} - 0.05$	1.5	$V_{REF} + 0.05$	V
V_{IH}	High level input voltage	-	$V_{REF} + 0.2$	-	$V_{CCIO} + 0.3$	V
V_{IL}	Low level input voltage	-	-0.3	-	$V_{REF} - 0.2$	V
V_{OH}	High level output voltage	$I_{OH} = -8 \text{ mA}$, $V_{CCIO} = 3\text{V}$	$V_{CCIO} - 1.1$	-	-	V
V_{OL}	Low level output voltage	$I_{OL} = 8 \text{ mA}$, $V_{CCIO} = 3\text{V}$	-	-	0.7	V

Notes:

1. V_{REF} should track the variations in V_{CCIO} , also peak to peak AC noise on V_{REF} may not exceed $\pm 2\% V_{REF}$.
2. V_{TT} of transmitting device must track V_{REF} of receiving devices.

HSTL1 DC Voltage Specifications

Symbol	Parameter	Test Conditions	Min.	Typ	Max.	Units
V_{CCIO}	Input source voltage		1.4	1.5	1.6	V
$V_{REF(1)}$	Input reference voltage		0.68	0.75	0.90	V
$V_{TT(2)}$	Termination voltage		-	$V_{CCIO} * 0.5$	-	V
V_{IH}	High level input voltage		$V_{REF} + 0.1$	-	1.9	V

Symbol	Parameter	Test Conditions	Min.	Typ	Max.	Units
V_{IL}	Low level input voltage		-0.3	-	$V_{REF} - 0.1$	V
V_{OH}	High level output voltage	$I_{OH} = -8 \text{ mA}$, $V_{CCIO} = 1.4\text{V}$	$V_{CCIO} - 0.4$	-	-	V
V_{OL}	Low level output voltage	$I_{OL} = 8 \text{ mA}$, $V_{CCIO} = 1.4\text{V}$	-	-	0.4	V

AC Electrical Characteristics Over Recommended Operating Conditions

Symbol	Parameter	-7		-10		Units
		Min.	Max.	Min.	Max.	
T _{PD1}	Propagation delay single p-term	-	7.1	-	9.2	ns
T _{PD2}	Propagation delay OR array	-	7.5	-	10.0	ns
T _{SUD}	Direct input register set-up time	4.1	-	4.2	-	ns
T _{SU1}	Setup time fast (single p-term)	3.2	-	3.3	-	ns
T _{SU2}	Setup time (OR array)	3.6	-	4.1	-	ns
T _{HD}	Direct input register hold time	0.0	-	0.0	-	ns
T _H	Hold time (OR array or p-term)	0.0	-	0.0	-	ns
T _{CO}	Clock to output	-	5.3	-	7.9	ns
F _{TOGGLE} ⁽¹⁾	Internal toggle rate	-	350	-	166	MHz
F _{SYSTEM1} ⁽²⁾	Maximum system frequency	-	217	-	125	MHz
F _{SYSTEM2} ⁽²⁾	Maximum system frequency	-	200	-	114	MHz
F _{EXT1} ⁽³⁾	Maximum external frequency	-	118	-	89	MHz
F _{EXT2} ⁽³⁾	Maximum external frequency	-	112	-	83	MHz
T _{PSUD}	Direct input register p-term clock setup time	2.3	-	2.5	-	ns
T _{PSU1}	P-term clock setup time (single p-term)	1.4	-	1.9	-	ns
T _{PSU2}	P-term clock setup time (OR array)	1.8	-	2.7	-	ns
T _{PHD}	Direct input register p-term clock hold time	0.9	-	0.4	-	ns
T _{PH}	P-term clock hold	1.8	-	1.3	-	ns
T _{PCO}	P-term clock to output	-	7.1	-	9.3	ns
T _{OE} /T _{OD}	Global OE to output enable/disable	-	6.0	-	9.2	ns
T _{POE} /T _{POD}	P-term OE to output enable/disable	-	7.0	-	10.2	ns
T _{MOE} /T _{MOD}	Macrocell driven OE to output enable/disable	-	8.0	-	12.5	ns
T _{PAO}	P-term set/reset to output valid	-	7.5	-	11.6	ns
T _{AO}	Global set/reset to output valid	-	6.0	-	11.5	ns
T _{SUEC}	Register clock enable setup time	3.3	-	3.4	-	ns
T _{HEC}	Register clock enable hold time	0.0	-	0.0	-	ns
T _{CW}	Global clock pulse width High or Low	1.4	-	3.0	-	ns
T _{PCW}	P-term pulse width High or Low	7.5	-	10.0	-	ns
T _{APRPW}	Asynchronous preset/reset pulse width (High or Low)	7.5	-	10.0	-	ns
T _{DGSU}	Set-up before DataGATE latch assertion	0.0		0.0		ns
T _{DGH}	Hold to DataGATE latch assertion	4.0		6.0		ns
T _{DGR}	DataGATE recovery to new data		8.5		11.0	ns
T _{DGW}	DataGATE low pulse width	3.0		5.0		ns
T _{CDRSU}	CDRST setup time before falling edge GCLK2	1.7		2.5		ns
T _{CDRH}	CDRST hold time before falling edge GCLK2	0.0		0.0		ns
T _{CONFIG}	Configuration time		200		200	μs

Notes:

1. F_{TOGGLE} is the maximum frequency of a T flip-flop can reliably toggle (see CoolRunner-II family data sheet).
2. F_{SYSTEM1} (1/T_{CYCLE}) is the internal operating frequency for a device with 16-bit Resettable binary counter through one p-term per macrocell while F_{SYSTEM2} is through the OR array (one counter per function block)
3. F_{EXT1}(1/T_{SU1}+T_{CO}) is the maximum external frequency using one p-term while F_{EXT2} is through the OR array
4. Typical configuration current during T_{CONFIG} is 25 mA.

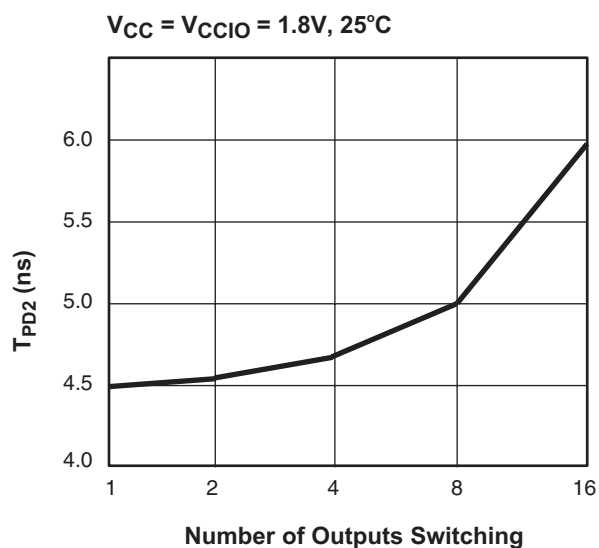
Internal Timing Parameters (Continued)

Symbol	Parameter ⁽¹⁾	-7		-10		Units
		Min.	Max.	Min.	Max.	
I/O Standard Time Adder Delays 3.3V CMOS/TTL						
T _{IN33}	Standard input adder	-	0.5	-	2.0	ns
T _{HYS33}	Hysteresis input adder	-	1.2	-	3.0	ns
T _{OUT33}	Output adder	-	1.2	-	3.0	ns
T _{SLEW33}	Output slew rate adder	-	3.0	-	4.0	ns
I/O Standard Time Adder Delays HSTL, SSTL						
SSTL2-1	Input adder to T _{IN} , T _{DIN} , T _{GCK} , T _{GSR} , T _{GTS}	-	0.8	-	2.5	ns
	Output adder to T _{OUT}	-	-0.5	-	0.0	ns
SSTL3-1	Input adder to T _{IN} , T _{DIN} , T _{GCK} , T _{GSR} , T _{GTS}	-	0.8	-	2.5	ns
	Output adder to T _{OUT}	-	-0.50	-	0.00	ns
HSTL-1	Input adder to T _{IN} , T _{DIN} , T _{GCK} , T _{GSR} , T _{GTS}	-	1.0	-	2.5	ns
	Output adder to T _{OUT}	-	0.0	-	0.0	ns

Notes:

1. 1.5 ns input pin signal rise/fall.

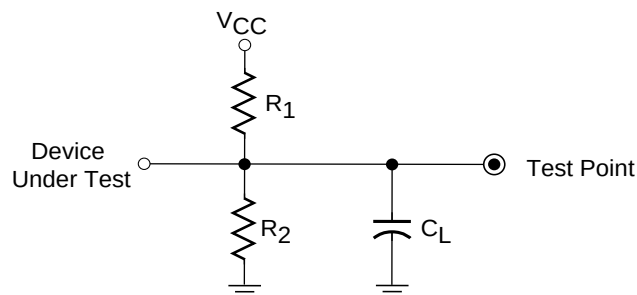
Switching Characteristics



DS095_02_053103

Figure 2: Derating Curve for T_{PD}

Switching Test Conditions



Output Type	R_1	R_2	C_L
LVTTL33	268 Ω	235 Ω	35 pF
LVC MOS33	275 Ω	275 Ω	35 pF
LVC MOS25	188 Ω	188 Ω	35 pF
LVC MOS18	112.5 Ω	112.5 Ω	35 pF
LVC MOS15	150 Ω	150 Ω	35 pF

Notes:

1. C_L includes test fixtures and probe capacitance.
2. 1.5 nsec maximum rise/fall times on inputs.

DS092_03_092302

Figure 3: AC Load Circuit

Typical I/V Output Curves

The I/V curve illustrates the nominal amount of current that an I/O can source/sink at different voltage levels.

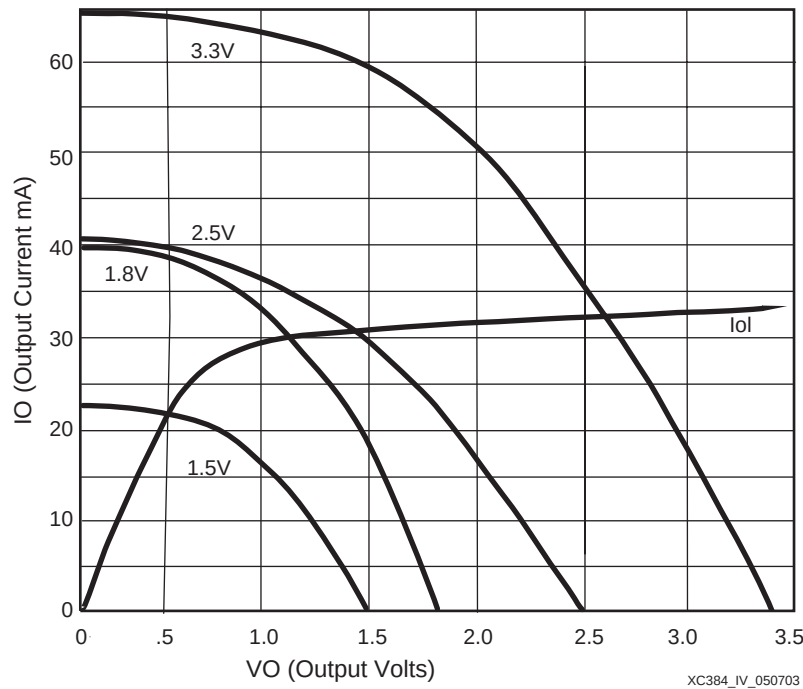


Figure 4: Typical I/V Curves for XC2C384

Pin Descriptions

Function Block	Macro-cell	TQ144	PQ208	FT256	FG324	I/O Bank
1	1	-	2	B3	C3	2
1	2	-	208	B4	A1	2
1(GSR)	3	143	206	C4	A2	2
1	4	142	205	A2	B3	2
1	5	-	-	-	C4	2
1	6	-	-	-	-	-
1	7	-	-	-	-	-
1	8	-	-	-	-	-
1	9	-	-	-	-	-
1	10	-	-	-	-	-
1	11	-	-	-	-	-
1	12	140	203	C5	B4	2
1	13	139	202	A3	C5	2
1	14	-	201	-	B5	2
1	15	-	200	E7	A3	2
1	16	-	199	-	A4	2

Pin Descriptions (Continued)

Function Block	Macro-cell	TQ144	PQ208	FT256	FG324	I/O Bank
2(GTS2)	1	2	3	D3	D3	2
2	2	-	4	C3	B2	2
2(GTS3)	3	3	5	E3	B1	2
2	4	4	6	B2	C2	2
2(GTS0)	5	5	7	D4	C1	2
2	6	-	-	-	-	-
2	7	-	-	-	-	-
2	8	-	-	-	-	-
2	9	-	-	-	-	-
2	10	-	-	-	-	-
2	11	-	-	-	-	-
2	12	-	-	A1	D2	2
2	13	-	8	D2	F4	2
2	14	-	-	C2	E2	2
2(GTS1)	15	6	9	E5	E1	2
2	16	7	10	B1	F2	2

Pin Descriptions (Continued)

Function Block	Macro-cell	TQ144	PQ208	FT256	FG324	I/O Bank
3	1	-	198	A4	D6	2
3	2	-	197	-	A5	2
3	3	138	196	C6	C6	2
3	4	137	195	B5	B6	2
3	5	136	194	D6	A6	2
3	6	-	-	-	-	-
3	7	-	-	-	-	-
3	8	-	-	-	-	-
3	9	-	-	-	-	-
3	10	-	-	-	-	-
3	11	-	-	-	-	-
3	12	135	193	A5	D7	2
3	13	-	192	E8	C7	2
3	14	-	-	B6	B7	2
3	15	-	191	C7	A7	2
3	16	134	-	A6	D8	2
4	1	9	12	E4	G4	2
4	2	10	-	C1	G3	2
4	3	11	14	E2	G2	2
4	4	12	15	F2	G1	2
4	5	-	16	E6	H4	2
4	6	-	-	-	-	-
4	7	-	-	-	-	-
4	8	-	-	-	-	-
4	9	-	-	-	-	-
4	10	-	-	-	-	-
4	11	-	-	-	-	-
4	12	-	17	F3	H3	2
4	13	-	18	D1	H2	2
4	14	-	19	G4	H1	2
4	15	-	20	E1	J3	2
4	16	-	21	G3	J2	2

Pin Descriptions (Continued)

Function Block	Macro-cell	TQ144	PQ208	FT256	FG324	I/O Bank
5	1	-	-	D7	C8	2
5	2	133	-	B7	B8	2
5	3	132	-	E9	A8	2
5	4	-	189	A7	D9	2
5	5	-	188	D8	C9	2
5	6	-	-	-	-	-
5	7	-	-	-	-	-
5	8	-	-	-	-	-
5	9	-	-	-	-	-
5	10	-	-	-	-	-
5	11	-	-	-	-	-
5	12	-	187	B8	B9	2
5	13	131	186	C8	A9	2
5	14	-	185	A8	D10	2
5	15	130	184	E11	C10	2
5	16	129	183	E10	B10	2
6	1	-	22	G2	J1	2
6	2	13	-	F5	K3	2
6	3	14	23	F1	K2	2
6	4	15	-	G5	K1	2
6	5	-	-	H2	L1	2
6	6	-	-	-	-	-
6	7	-	-	-	-	-
6	8	-	-	-	-	-
6	9	-	-	-	-	-
6	10	-	-	-	-	-
6	11	-	-	-	-	-
6	12	-	-	H4	L3	2
6	13	16	-	G1	L2	2
6	14	17	-	H3	M1	2
6	15	-	-	H1	M2	2
6	16	18	25	H5	M3	2

Pin Descriptions (Continued)

Function Block	Macro-cell	TQ144	PQ208	FT256	FG324	I/O Bank
7(CDRST)	1	35	51	P2	AB2	1
7	2	-	50	N3	AA2	1
7	3	-	49	R1	AA1	1
7	4	34	48	N4	W4	1
7	5	33	47	N2	Y2	1
7	6	-	-	-	-	-
7	7	-	-	-	-	-
7	8	-	-	-	-	-
7	9	-	-	-	-	-
7	10	-	-	-	-	-
7	11	-	-	-	-	-
7(GCK1)	12	32	46	M3	Y1	1
7	13	-	-	P1	W2	1
7	14	31	45	M4	W1	1
7(GCK0)	15	30	44	M2	V3	1
7	16	-	43	L3	U4	1
8	1	-	54	P4	Y4	1
8(GCK2)	2	38	55	P5	AB3	1
8	3	-	56	R2	AA4	1
8	4	-	57	T1	Y5	1
8(DGE)	5	39	58	T2	AA5	1
8	6	-	-	-	-	-
8	7	-	-	-	-	-
8	8	-	-	-	-	-
8	9	-	-	-	-	-
8	10	-	-	-	-	-
8	11	-	-	-	-	-
8	12	-	-	-	AB4	1
8	13	40	60	N5	W6	1
8	14	41	-	-	AB5	1
8	15	42	61	R4	Y6	1
8	16	43	-	M5	AA6	1

Pin Descriptions (Continued)

Function Block	Macro-cell	TQ144	PQ208	FT256	FG324	I/O Bank
9	1	-	41	N1	V2	1
9	2	28	40	L4	V1	1
9	3	-	39	M1	U3	1
9	4	-	38	L5	U2	1
9	5	-	37	K4	U1	1
9	6	-	-	-	-	-
9	7	-	-	-	-	-
9	8	-	-	-	-	-
9	9	-	-	-	-	-
9	10	-	-	-	-	-
9	11	--	-	-	-	-
9	12	-	36	L2	T4	1
9	13	-	35	K3	T3	1
9	14	-	34	L1	T2	1
9	15	26	32	-	T1	1
9	16	25	-	-	R4	1
10	1	44	62	-	AB6	1
10	2	45	63	R5	W7	1
10	3	-	-	-	Y7	1
10	4	46	64	R6	AA7	1
10	5	-	65	N6	AB7	1
10	6	-	-	-	-	-
10	7	-	-	-	-	-
10	8	-	-	-	-	-
10	9	-	-	-	-	-
10	10	-	-	-	-	-
10	11	-	-	-	-	-
10	12	-	66	R3	W8	1
10	13	-	67	M6	Y8	1
10	14	48	69	-	AA8	1
10	15	49	70	T3	AB8	1
10	16	50	71	P6	Y9	1

Pin Descriptions (Continued)

Function Block	Macro-cell	TQ144	PQ208	FT256	FG324	I/O Bank
11	1	24	31	K5	R3	1
11	2	23	-	K2	R2	1
11	3	22	30	J4	R1	1
11	4	21	29	K1	P4	1
11	5	20	28	J3	P3	1
11	6	-	-	-	-	-
11	7	-	-	-	-	-
11	8	-	-	-	-	-
11	9	-	-	-	-	-
11	10	-	-	-	-	-
11	11	-	-	-	-	-
11	12	19	27	J2	P2	1
11	13	-	-	J5	P1	1
11	14	-	-	J1	N3	1
11	15	-	-	-	N2	1
11	16	-	-	-	N1	1
12	1	51	72	T4	AA9	1
12	2	52	73	P7	AB9	1
12	3	53	74	T5	W10	1
12	4	-	75	N7	Y10	1
12	5	54	76	R7	AA10	1
12	6	-	-	-	-	-
12	7	-	-	-	-	-
12	8	-	-	-	-	-
12	9	-	-	-	-	-
12	10	-	-	-	-	-
12	11	-	-	-	-	-
12	12	-	77	M7	AB10	1
12	13	-	-	-	AB11	1
12	14	-	-	-	W11	1
12	15	-	-	-	AA11	1
12	16	-	78	T6	Y11	1

Pin Descriptions (Continued)

Function Block	Macro-cell	TQ144	PQ208	FT256	FG324	I/O Bank
13	1	-	-	B16	C21	4
13	2	-	-	G11	C20	4
13	3	112	160	C14	B22	4
13	4	113	161	B15	B21	4
13	5	-	-	A16	A22	4
13	6	-	-	-	-	-
13	7	-	-	-	-	-
13	8	-	-	-	-	-
13	9	-	-	-	-	-
13	10	-	-	-	-	-
13	11	-	-	-	-	-
13	12	114	162	B13	A21	4
13	13	115	163	B14	B20	4
13	14	-	-	C13	C19	4
13	15	-	-	A15	B19	4
13	16	-	164	C12	C18	4
14	1	111	159	D14	D19	4
14	2	110	158	C15	D20	4
14	3	107	155	G12	C22	4
14	4	106	154	D15	D21	4
14	5	105	153	E14	D22	4
14	6	-	-	-	-	-
14	7	-	-	-	-	-
14	8	-	-	-	-	-
14	9	-	-	-	-	-
14	10	-	-	-	-	-
14	11	-	-	-	-	-
14	12	-	-	C16	E20	4
14	13	104	152	F14	F19	4
14	14	-	151	D16	E21	4
14	15	-	-	F13	E22	4
14	16	-	150	E15	F20	4

Pin Descriptions (Continued)

Function Block	Macro-cell	TQ144	PQ208	FT256	FG324	I/O Bank
15	1	-	-	B12	B18	4
15	2	116	165	D13	A19	4
15	3	-	166	A14	D17	4
15	4	-	-	E13	A18	4
15	5	117	167	A13	C17	4
15	6	-	-	-	-	-
15	7	-	-	-	-	-
15	8	-	-	-	-	-
15	9	-	-	-	-	-
15	10	-	-	-	-	-
15	11	-	-	-	-	-
15	12	-	168	C11	B17	4
15	13	118	169	A12	D16	4
15	14	-	-	B11	C16	4
15	15	119	170	D11	B16	4
15	16	120	171	A11	D15	4
16	1	103	149	G13	F21	4
16	2	-	148	F15	F22	4
16	3	102	147	G14	G19	4
16	4	-	146	E16	G20	4
16	5	-	-	H12	G21	4
16	6	-	-	-	-	-
16	7	-	-	-	-	-
16	8	-	-	-	-	-
16	9	-	-	-	-	-
16	10	-	-	-	-	-
16	11	-	-	-	-	-
16	12	-	145	F16	G22	4
16	13	-	-	H16	H19	4
16	14	101	144	-	H21	4
16	15	-	-	-	H22	4
16	16	100	143	-	J19	4

Pin Descriptions (Continued)

Function Block	Macro-cell	TQ144	PQ208	FT256	FG324	I/O Bank
17	1	-	173	D10	C15	4
17	2	121	174	B10	B15	4
17	3	-	175	E12	D14	4
17	4	-	-	-	B14	4
17	5	-	-	F12	C13	4
17	6	-	-	-	-	-
17	7	-	-	-	-	-
17	8	-	-	-	-	-
17	9	-	-	-	-	-
17	10	-	-	-	-	-
17	11	-	-	-	-	-
17	12	124	178	B9	A13	4
17	13	125	179	C9	D12	4
17	14	126	180	C10	C12	4
17	15	-	-	A9	B11	4
17	16	128	182	D9	A10	4
18	1	-	-	G15	J20	4
18	2	-	142	-	J21	4
18	3	98	140	-	J22	4
18	4	97	139	H13	K19	4
18	5	96	138	G16	K20	4
18	6	-	-	-	-	-
18	7	-	-	-	-	-
18	8	-	-	-	-	-
18	9	-	-	-	-	-
18	10	-	-	-	-	-
18	11	-	-	-	-	-
18	12	95	137	H14	K21	4
18	13	94	136	H15	K22	4
18	14	-	135	J12	L19	4
18	15	-	134	K12	L20	4
18	16	-	-	J16	L21	4

Pin Descriptions (Continued)

Function Block	Macro-cell	TQ144	PQ208	FT256	FG324	I/O Bank
23	1	-	-	L16	P20	3
23	2	-	125	K15	P21	3
23	3	85	126	L12	N19	3
23	4	86	127	-	N21	3
23	5	87	-	K16	N22	3
23	6	-	-	-	-	-
23	7	-	-	-	-	-
23	8	-	-	-	-	-
23	9	-	-	-	-	-
23	10	-	-	-	-	-
23	11	-	-	-	-	-
23	12	88	128	J14	M22	3
23	13	91	-	J15	M19	3
23	14	92	131	J13	M20	3
23	15	-	-	-	M21	3
23	16	-	-	-	L22	3

Pin Descriptions (Continued)

Function Block	Macro-cell	TQ144	PQ208	FT256	FG324	I/O Bank
24	1	-	-	N9	Y14	3
24	2	58	84	T9	AA14	3
24	3	-	-	-	AB14	3
24	4	-	83	-	Y13	3
24	5	-	82	M8	AA13	3
24	6	-	-	-	-	-
24	7	-	-	-	-	-
24	8	-	-	-	-	-
24	9	-	-	-	-	-
24	10	-	-	-	-	-
24	11	-	-	-	-	-
24	12	57	-	T8	AB13	3
24	13	-	-	P8	W12	3
24	14	56	80	R8	Y12	3
24	15	-	-	T7	AA12	3
24	16	-	-	N8	AB12	3

Notes:

1. GTS = global output enable, GSR = global reset/set, GCK = global clock, CDRST = clock divide reset, DGE = DataGATE enable.
2. GCK, GSR, and GTS pins can also be used for general purpose I/O.

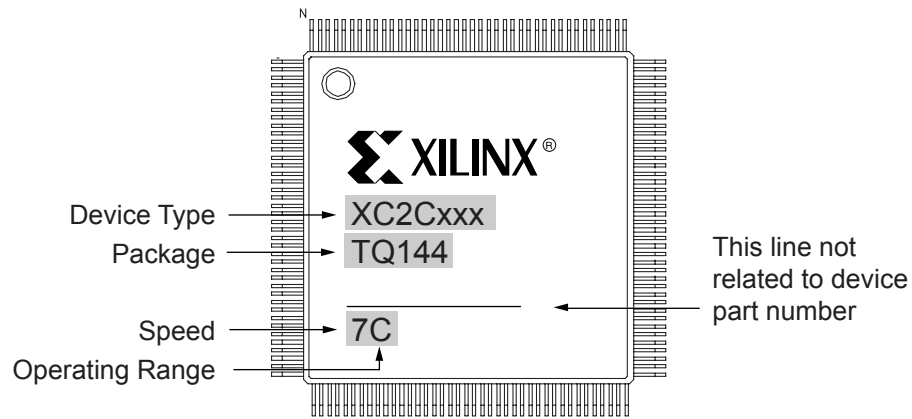
XC2C384 JTAG, Power/Ground, No Connect Pins and Total User I/O

Pin Type	TQ144	PQ208	FT256	FG324
TCK	67	98	P12	Y19
TDI	63	94	R11	AB19
TDO	122	176	A10	C14
TMS	65	96	N12	AB20
V _{CCAUX} (JTAG supply voltage)	8	11	F4	F1
Power internal (V _{CC})	1, 37, 84	1, 53, 124	P3, K13, D12, D5	AA3, N20, A20, D4, E3
Power Bank 1 I/O (V _{CCIO1})	27, 55	33, 59, 79	J6, K6, L7, L8	M9, N9, P10, P11
Power Bank 2 I/O (V _{CCIO2})	141	26, 204	F7, F8, G6, H6	J10, J11, K9, L9
Power Bank 3 I/O (V _{CCIO3})	73, 93	92, 105, 132	J11, K11, L10, L9	M14, N14, P12, P13
Power Bank 4 I/O (V _{CCIO4})	109, 127	133, 157, 172, 181	F10, F9, H11	J12, J13, K14, L14

XC2C384 JTAG, Power/Ground, No Connect Pins and Total User I/O (Continued)

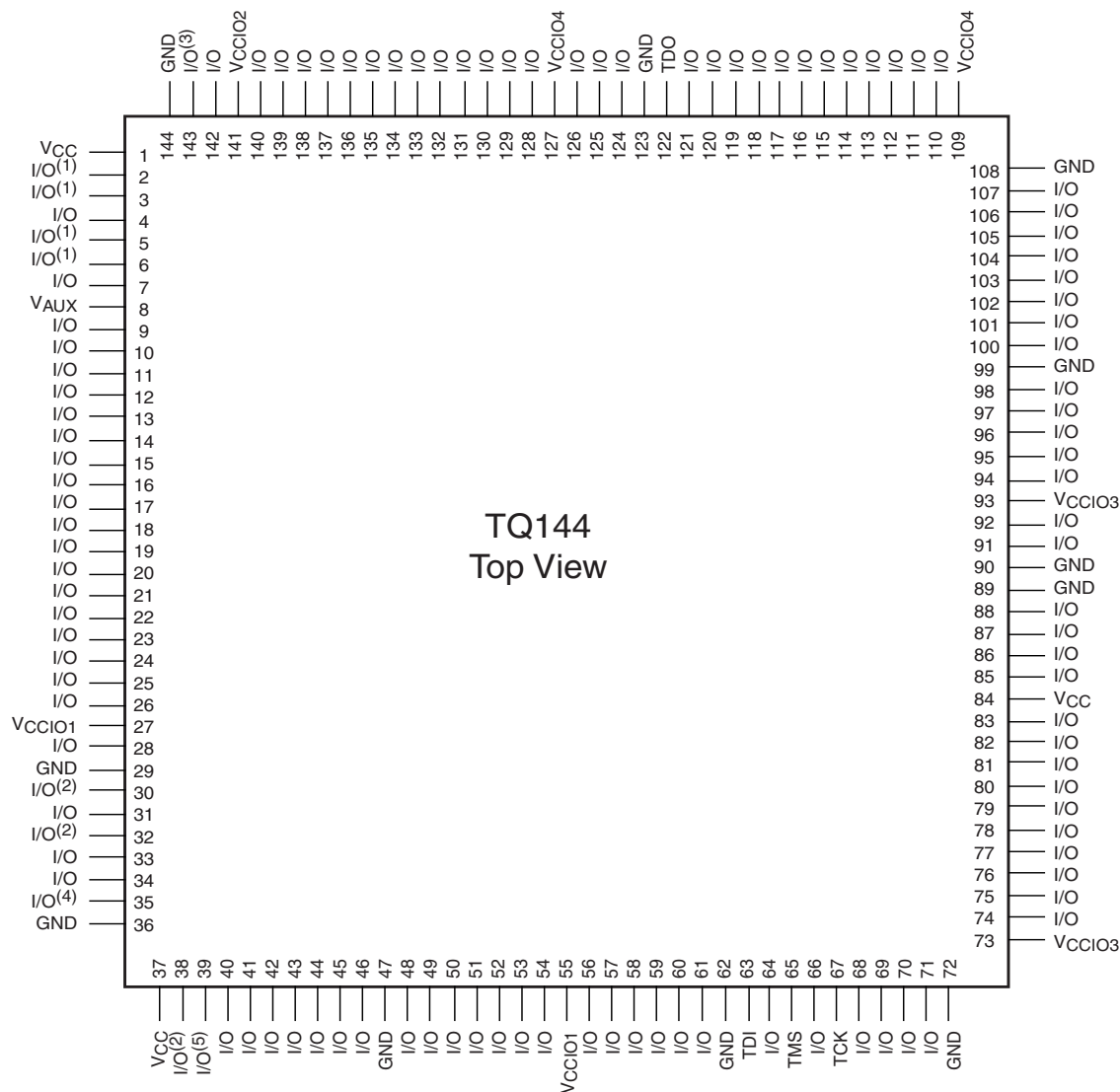
Pin Type	TQ144	PQ208	FT256	FG324
Ground	29, 36, 47, 62, 72, 89, 90, 99, 108, 123, 144	13, 24, 42, 52, 68, 81, 93, 104, 129, 130, 141, 156, 177, 190, 207	F11, F6, G10, G7, G8, G9, H10, H7, H8, H9, J10, J7, J8, J9, K10, K7, K8, K9, L11, L6	D5, D18, E4, E19, J9, J14, K10, K11, K12, K13, L10, L11, L12, L13, M10, M11, M12, M13, N10, N11, N12, N13, P9, P14, V4, V19, W5, W18
No connects	-	-		A11,A12,A14,A15,A16,A17,B 12,B13,C11,D1,D11,D13,F3,H 20,J4,K4,L4,M4,N4,P19,P22, R19,R20,W3,W9,W13,W16,W 17,Y3,AB1
Total user I/O (includes dual function pins)	118	173	212	240

Device Part Marking



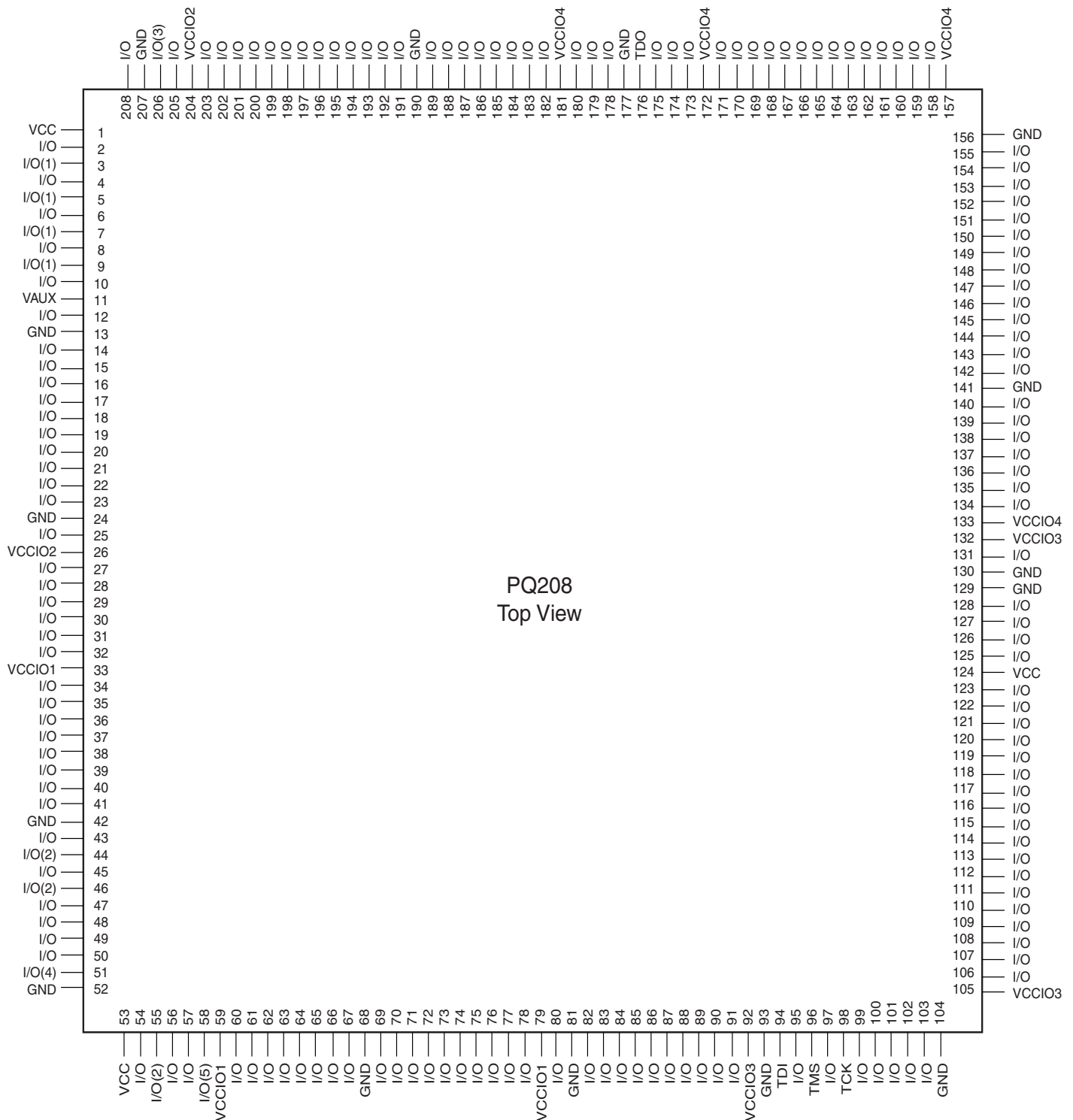
Part marking for non-chip scale package

Figure 5: Sample Package with Part Marking



- (1) - Global Output Enable
- (2) - Global Clock
- (3) - Global Set/Reset
- (4) - Clock Divide Reset
- (5) - DataGATE Enable

Figure 6: TQ144 Thin Quad Flat Pack



- (1) - Global Output Enable
- (2) - Global Clock
- (3) - Global Set/Reset
- (4) - Clock Divide Reset
- (5) - DataGATE Enable

Figure 7: PQ208 Plastic Quad Flat Package

	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1
A	I/O	I/O	I/O	I/O	I/O	I/O	TDO	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O
B	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O
C	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O(3)	I/O	I/O	I/O
D	I/O	I/O	I/O	I/O	VCC	I/O	I/O	I/O	I/O	I/O	I/O	VCC	I/O(1)	I/O(1)	I/O	I/O
E	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O(1)	I/O	I/O(1)	I/O	I/O
F	I/O	I/O	I/O	I/O	I/O	GND	VCCIO4	VCCIO4	VCCIO2	VCCIO2	GND	I/O	VAUX	I/O	I/O	I/O
G	I/O	I/O	I/O	I/O	I/O	I/O	GND	GND	GND	GND	VCCIO2	I/O	I/O	I/O	I/O	I/O
H	I/O	I/O	I/O	I/O	I/O	VCCIO4	GND	GND	GND	GND	VCCIO2	I/O	I/O	I/O	I/O	I/O
J	I/O	I/O	I/O	I/O	I/O	VCCIO3	GND	GND	GND	GND	VCCIO1	I/O	I/O	I/O	I/O	I/O
K	I/O	I/O	I/O	VCC	I/O	VCCIO3	GND	GND	GND	GND	VCCIO1	I/O	I/O	I/O	I/O	I/O
L	I/O	I/O	I/O	I/O	I/O	GND	VCCIO3	VCCIO3	VCCIO1	VCCIO1	GND	I/O	I/O	I/O	I/O	I/O
M	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O(2)	I/O(2)	I/O
N	I/O	I/O	I/O	I/O	TMS	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O
P	I/O	I/O	I/O	I/O	TCK	I/O	I/O	I/O	I/O	I/O	I/O	I/O(2)	I/O	VCC	I/O(4)	I/O
R	I/O	I/O	I/O	I/O	I/O	TDI	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O
T	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O	I/O(5)	I/O

FT256 Bottom View

- (1) - Global Output Enable
- (2) - Global Clock
- (3) - Global Set/Reset
- (4) - Clock Divide Reset
- (5) - DataGATE Enable

Figure 8: FT256 Fine Pitch Thin BGA

Warranty Disclaimer

THESE PRODUCTS ARE SUBJECT TO THE TERMS OF THE XILINX LIMITED WARRANTY WHICH CAN BE VIEWED AT <http://www.xilinx.com/warranty.htm>. THIS LIMITED WARRANTY DOES NOT EXTEND TO ANY USE OF THE PRODUCTS IN AN APPLICATION OR ENVIRONMENT THAT IS NOT WITHIN THE SPECIFICATIONS STATED ON THE THEN-CURRENT XILINX DATA SHEET FOR THE PRODUCTS. PRODUCTS ARE NOT DESIGNED TO BE FAIL-SAFE AND ARE NOT WARRANTED FOR USE IN APPLICATIONS THAT POSE A RISK OF PHYSICAL HARM OR LOSS OF LIFE. USE OF PRODUCTS IN SUCH APPLICATIONS IS FULLY AT THE RISK OF CUSTOMER SUBJECT TO APPLICABLE LAWS AND REGULATIONS.

Additional Information

Additional information is available for the following CoolRunner-II topics:

- XAPP784: Bulletproof CPLD Design Practices
- XAPP375: Timing Model
- XAPP376: Logic Engine
- XAPP378: Advanced Features
- XAPP382: I/O Characteristics
- XAPP389: Powering CoolRunner-II
- XAPP399: Assigning VREF Pins

To access these and all application notes with their associated reference designs, click the following link and scroll down the page until you find the document you want:

[CoolRunner-II Data Sheets and Application Notes](#)
[Device Packages](#)

Revision History

The following table shows the revision history for this document.

Date	Version	Revision
5/31/02	1.0	Initial Xilinx release
9/23/02	1.1	Updated FT256 and TQ144 pinouts
4/16/03	1.2	Updated FG324 package, updated No Connect pins
5/30/03	2.0	Added -6, -10 characterization data
11/7/03	2.1	Corrected typo on page 1. 324-ball FG BGA package has ball pitch of 1.0mm
1/26/04	2.2	Added links to Application notes and Data sheets
5/7/04	2.3	Corrected error in package dimensions of XC2C384-10TQ144I
8/03/04	2.4	Pb-free documentation
10/01/04	2.5	Add Asynchronous Preset/Reset Pulse Width specification to AC Electrical Characteristics
01/30/05	2.6	Change to I _{CCSB} MAX for Industrial devices
03/07/05	2.7	Deleted -6 speed grade. Modifications to Table 1, IOSTANDARDS
2/06/06	2.8	Change to T _{SU1} for -7 speed grade. Previous value was typographical error
03/20/06	2.9	Add Warranty Disclaimer. Add note to Pin Descriptions that GCK, GSR, and GTS pins can also be used for general purpose I/O

Date	Version	Revision
07/14/06	3.0	Move to Product Specification. Changes to - 7 speed grade: T_{SUD} , T_{SU1} , T_{SU2} , T_{CO} , T_{PCO} , T_F , F_{EXT1} , T_{GCK} , T_{ECSU} , T_{COI} , T_{SUEC} , T_{CW} and F_{EXT2} . Changes to -10 speed grade: T_{SUD} , T_{SU1} , T_{SU2} , T_{PSUD} , $F_{SYSTEM1}$, $F_{SYSTEM2}$, F_{EXT} , and F_{EXT2} . Change to Test Conditions for V_{OH} and V_{OL} on HSTL1 DC Voltage Specifications, page 5 (V_{CCIO} goes to 1.4V from 1.7V).
02/15/07	3.1	Corrections to timing parameters t_{OEM} for -6 speed grade, and to t_{DIN} , t_{SUI} , t_{ECSU} , t_{PSU1} , t_{PSU2} , t_{PHD} , and t_{SUEC} for the -7 speed grade. Values now match the software. There were no changes to silicon or characterization. Change to V_{IH} specification for 2.5V and 1.8V LVCMOS.
03/08/07	3.2	Fixed typo in note for V_{IL} for LVCMOS18; removed note for V_{IL} for LVCMOS33.

